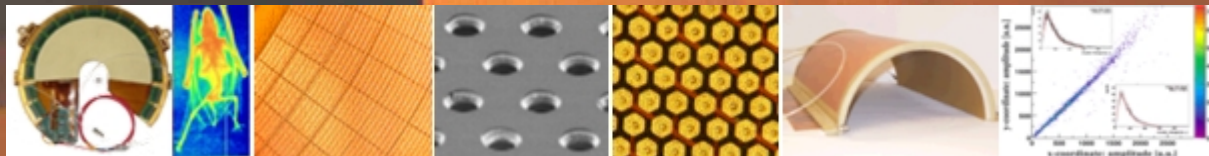
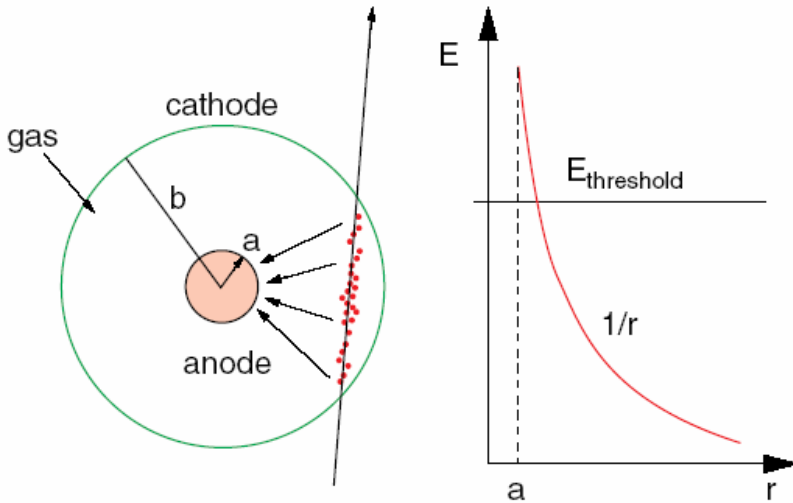


# Introduction to TOTEM T2 DCS

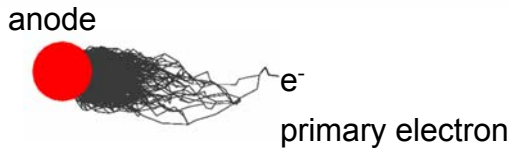
Leszek Ropelewski CERN PH-DT2-ST & TOTEM



# Single Wire Proportional Chamber



Electrons liberated by ionization drift towards the anode wire.  
 Electrical field close to the wire (typical wire  $\varnothing$  ~few tens of  $\mu\text{m}$ ) is sufficiently high for electrons (above 10 kV/cm) to gain enough energy to ionize further  $\rightarrow$  **avalanche** - exponential increase of number of electron ion pairs.



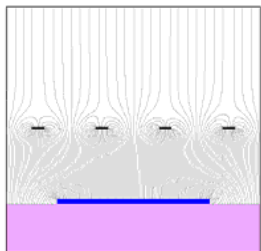
JV\_2816

$$E(r) = \frac{CV_0}{2\pi\epsilon_0} \cdot \frac{1}{r}$$

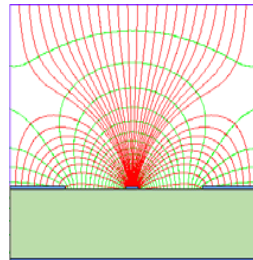
$C$  – capacitance/unit length

$$V(r) = \frac{CV_0}{2\pi\epsilon_0} \cdot \ln \frac{r}{a}$$

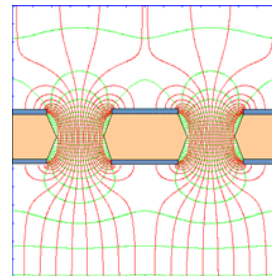
Cylindrical geometry is not the only one able to generate strong electric field:



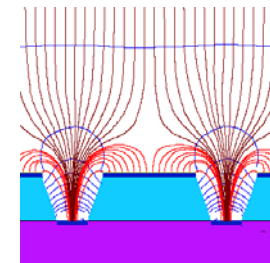
parallel plate



strip

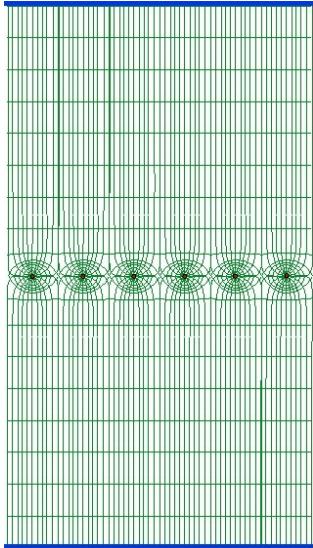


hole



groove

# Multiwire Proportional Chamber



Simple idea to multiply SWPC cell : Nobel Prize 1992

First electronic device allowing high statistics experiments !!



Typical geometry  
5mm, 1mm, 20  $\mu\text{m}$

Normally digital readout :  
spatial resolution limited to

$$\sigma_x \approx \frac{d}{\sqrt{12}}$$

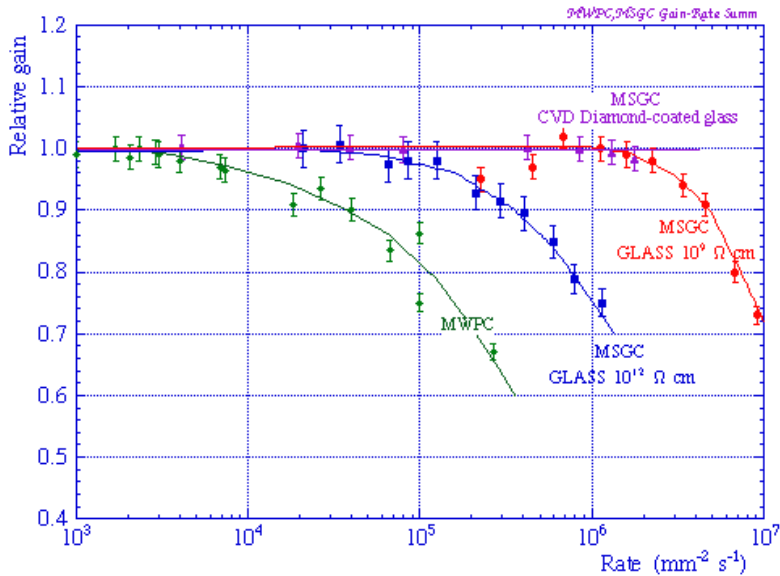
for  $d = 1 \text{ mm}$   $\sigma_x = 300 \mu\text{m}$



G. Charpak, F. Sauli and J.C. Santiard



# Micropattern Gas Detectors



Advantages of gas detectors:

- low radiation length
- large areas at low price
- flexible geometry
- spatial, energy resolution ...

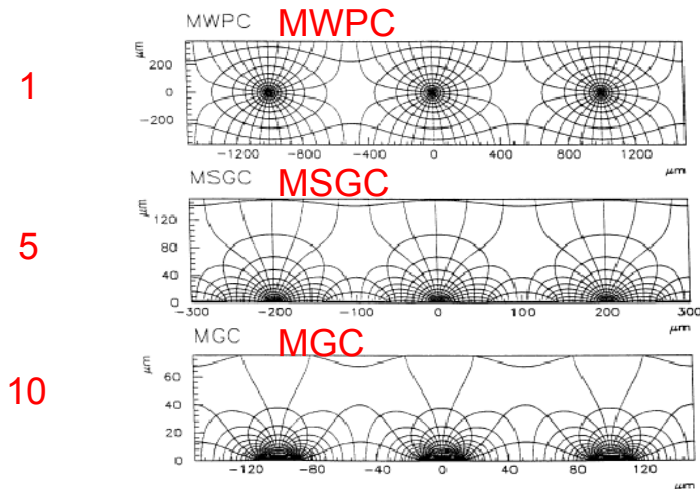
Problem:

- rate capability limited by space charge defined by the time of evacuation of positive ions

Solution:

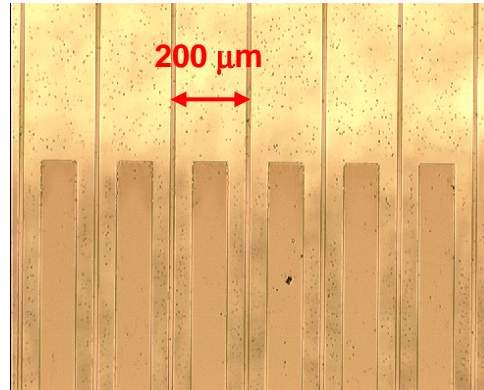
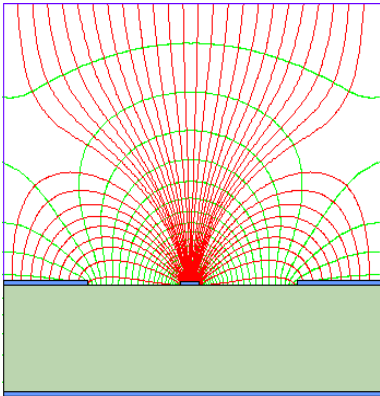
- reduction of the size of the detecting cell (limitation of the length of the ion path) using chemical etching techniques developed for microelectronics and keeping at same time similar field shape.

scale factor



R. Bellazzini et al.

# MSGC - Microstrip Gas Chamber

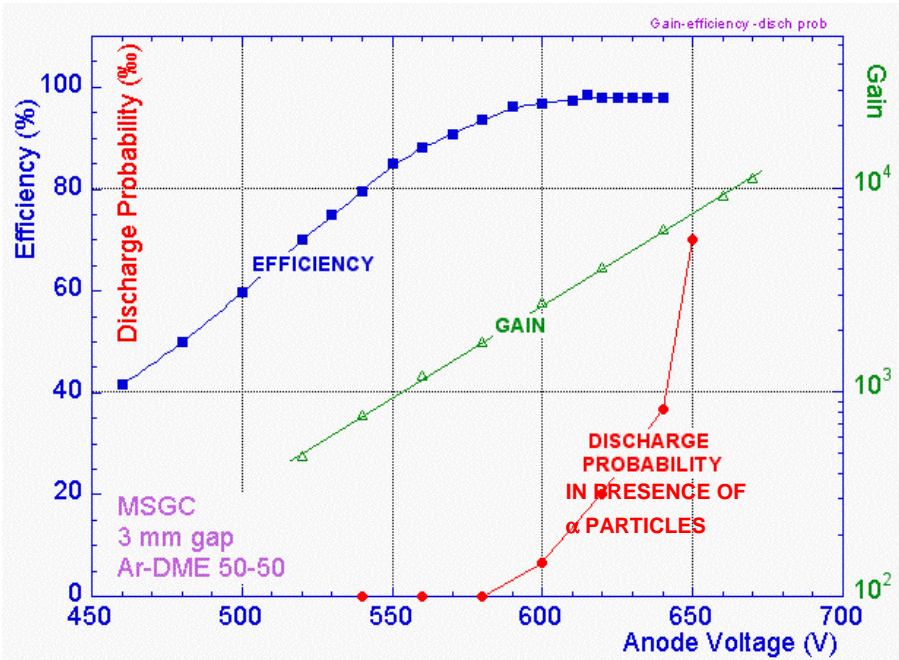


Thin metal anodes and cathodes on insulating support (glass, flexible polyimide ..)

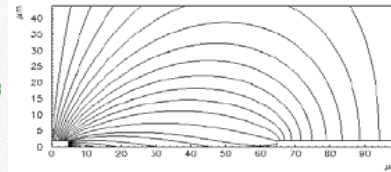
Problems:

High discharge probability under exposure to highly ionizing particles caused by the regions of very high E field on the border between conductor and insulator.

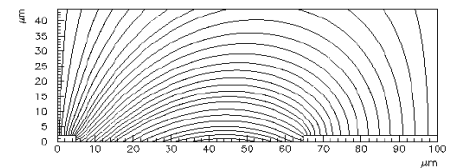
Charging up of the insulator and modification of the E field → time evolution of the gain.



insulating support



slightly conductive support



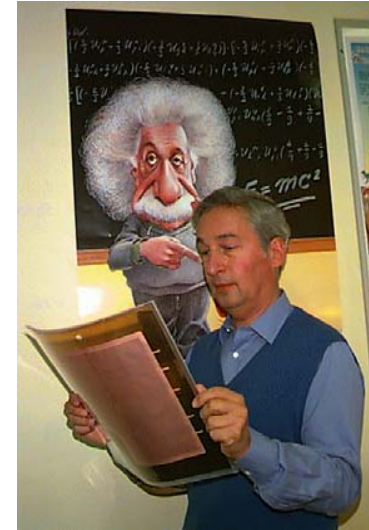
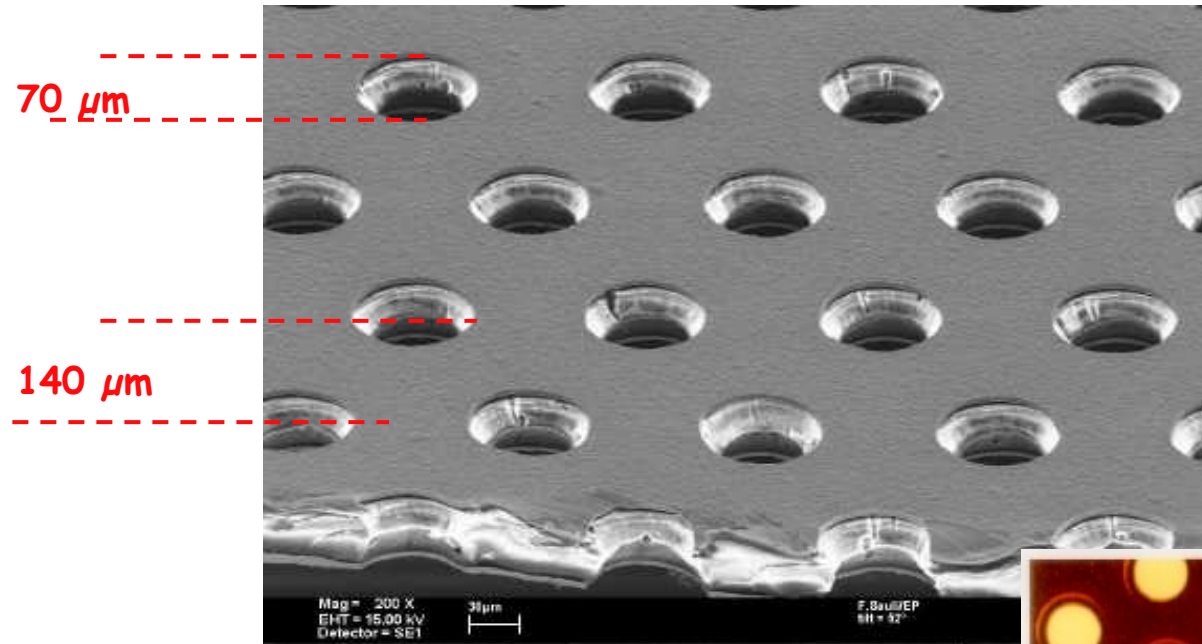
R. Bellazzini et al.

Solutions:

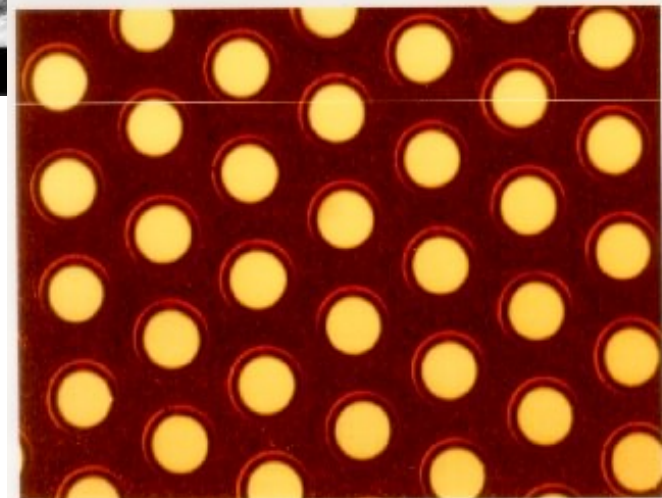
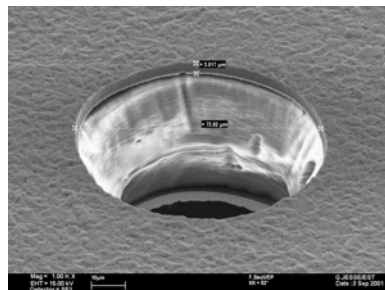
slightly conductive support  
multistage amplification

# GEM: Gas Electron Multiplier

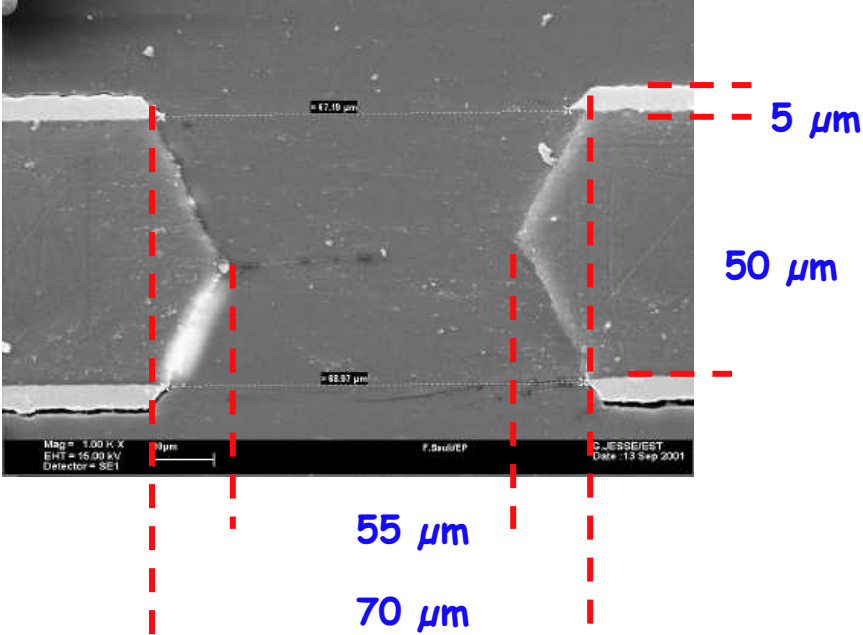
Thin metal-coated polymer foil pierced by a high density of holes (50-100/mm<sup>2</sup>)  
Typical geometry: 5 μm Cu on 50 μm Kapton, 70 μm holes at 140 μm pitch



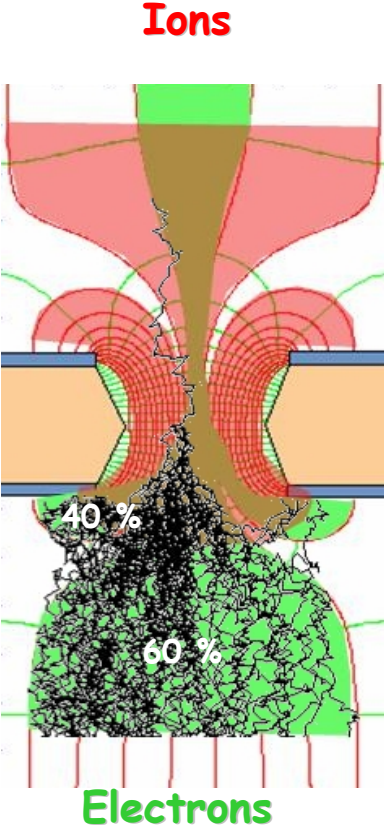
F. Sauli, Nucl. Instrum. Methods A386(1997)531



# GEM Principle



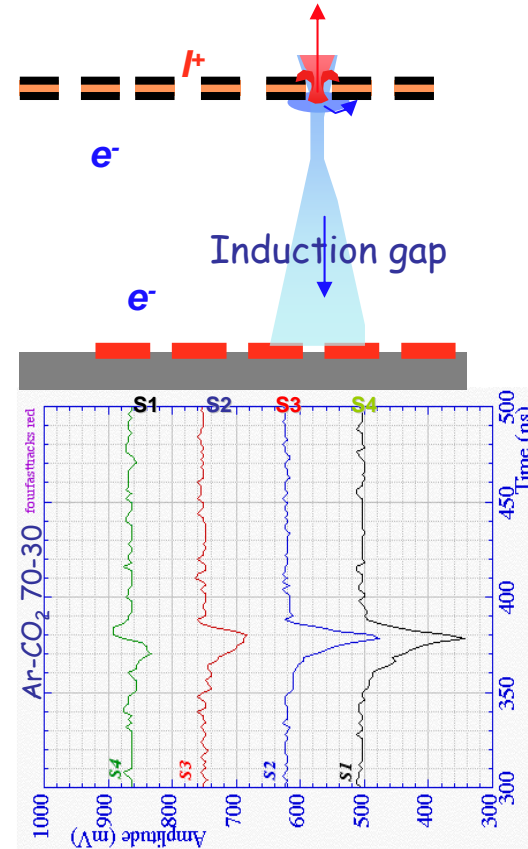
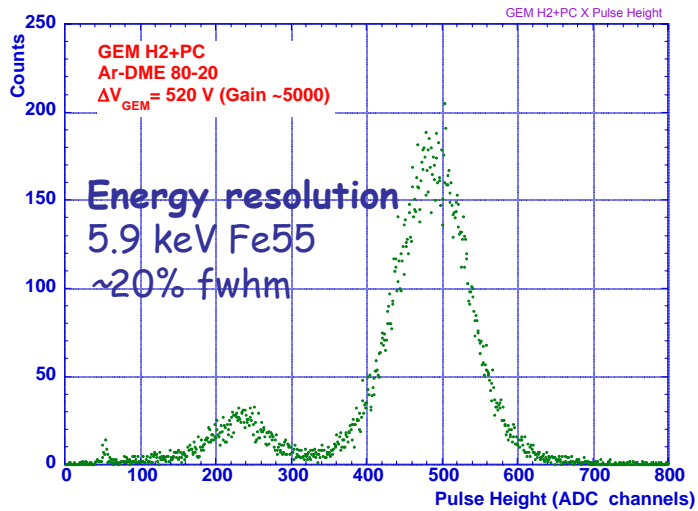
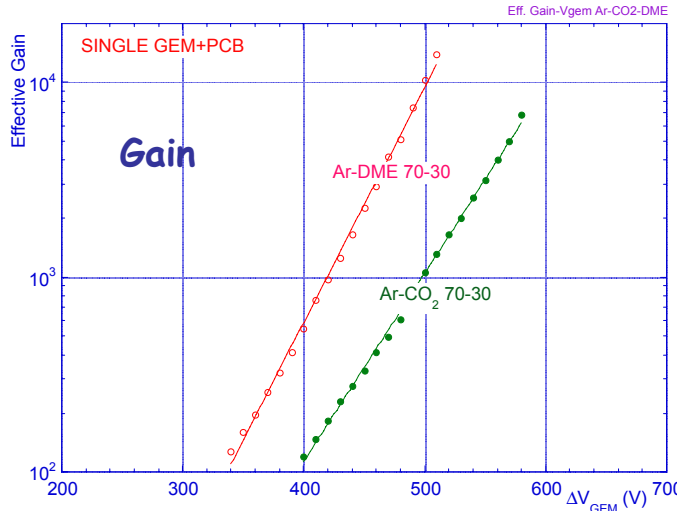
GEM hole cross section



Avalanche simulation



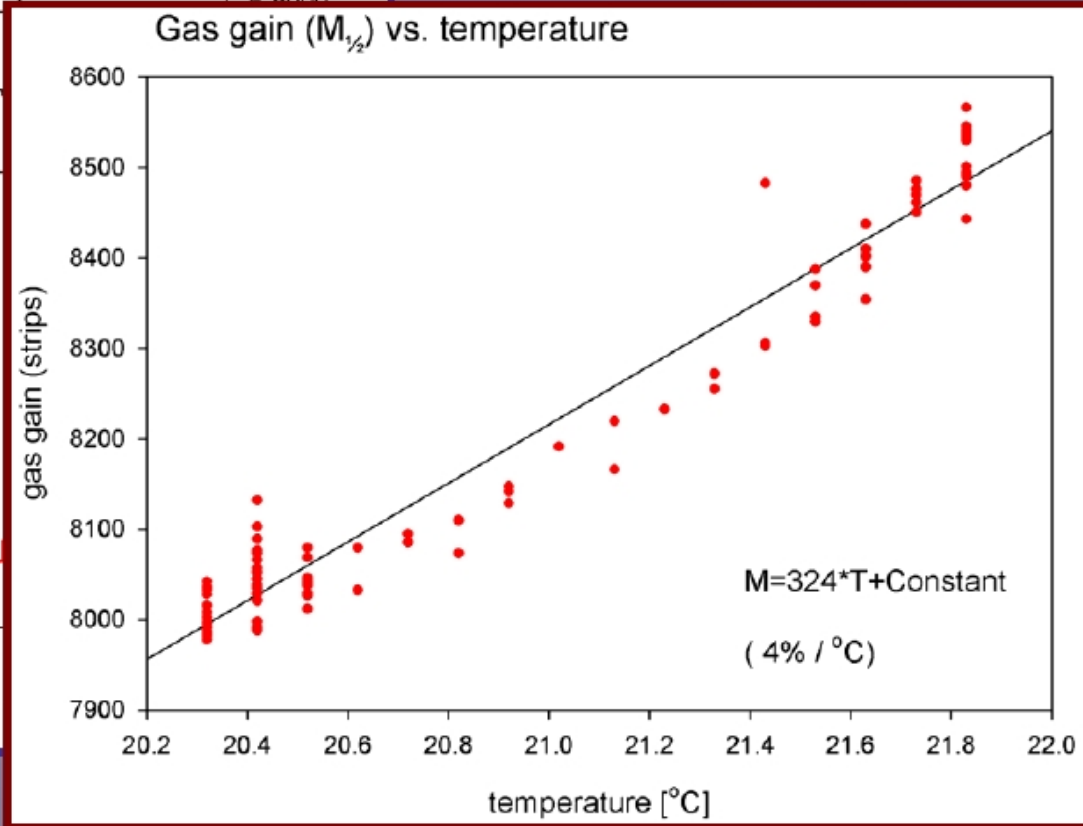
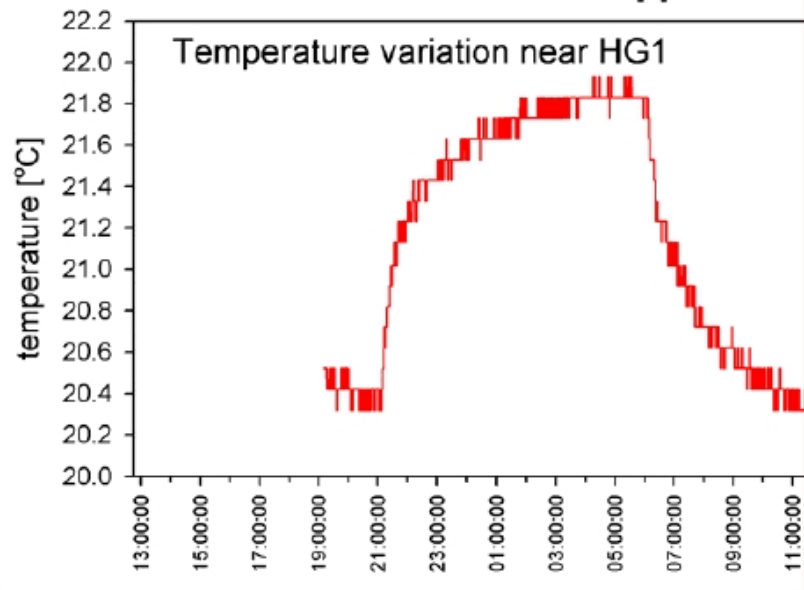
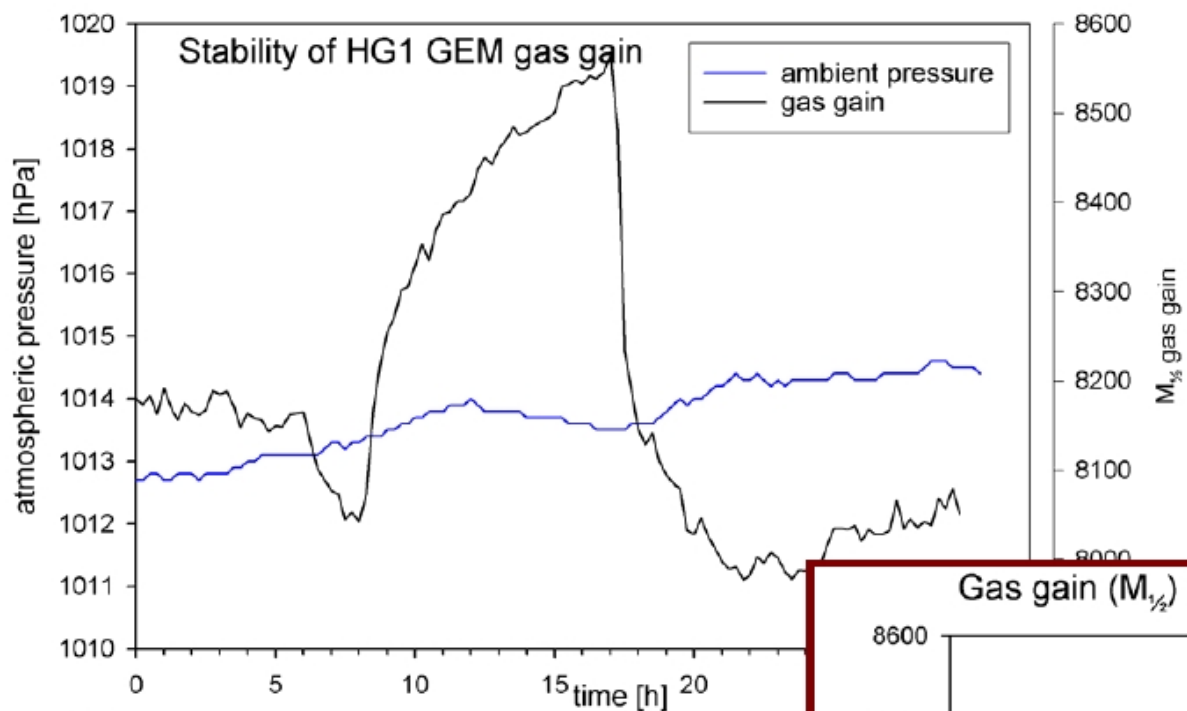
# Single GEM Performances



Electrons are collected on patterned readout board.  
A fast signal can be detected on the lower GEM electrode  
for triggering or energy discrimination.  
All readout electrodes are at ground potential.  
Positive ions partially collected on the GEM electrodes.



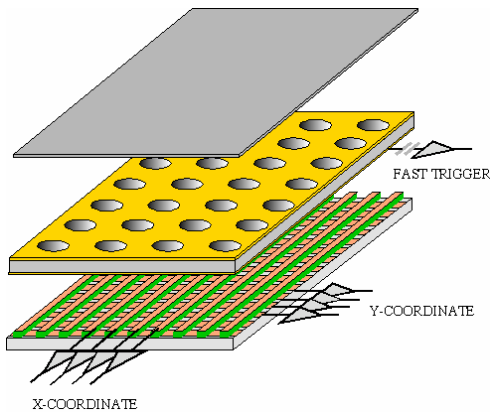
# GAIN STABILITY



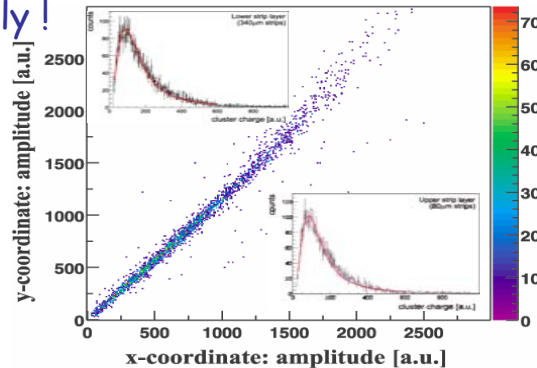
# GEM - Gas Electron Multiplier

Full decoupling of the charge amplification structure from the charge collection and readout structure.

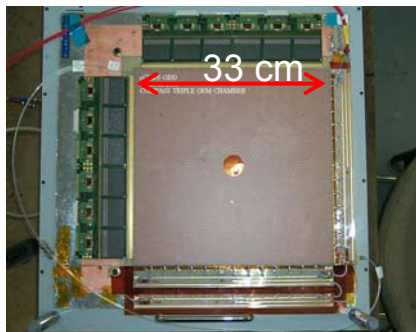
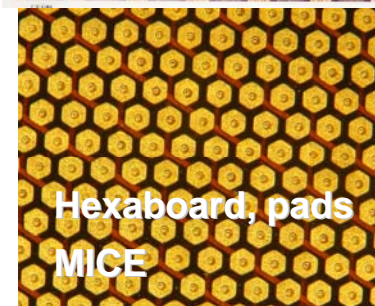
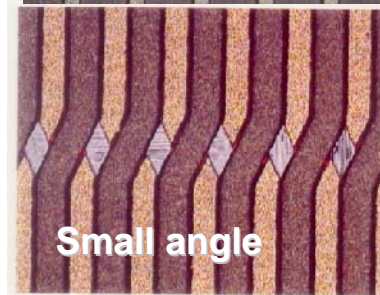
Both structures can be optimized independently!



A. Bressan et al, Nucl. Instr. and Meth. A425(1999)254



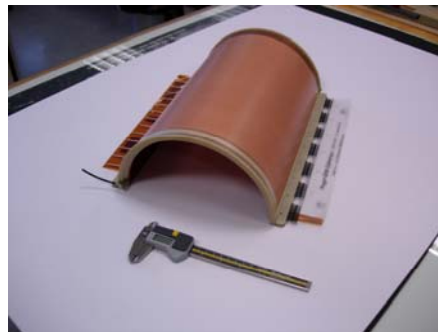
Charge correlation (Cartesian readout)



**Compass**



**Totem**



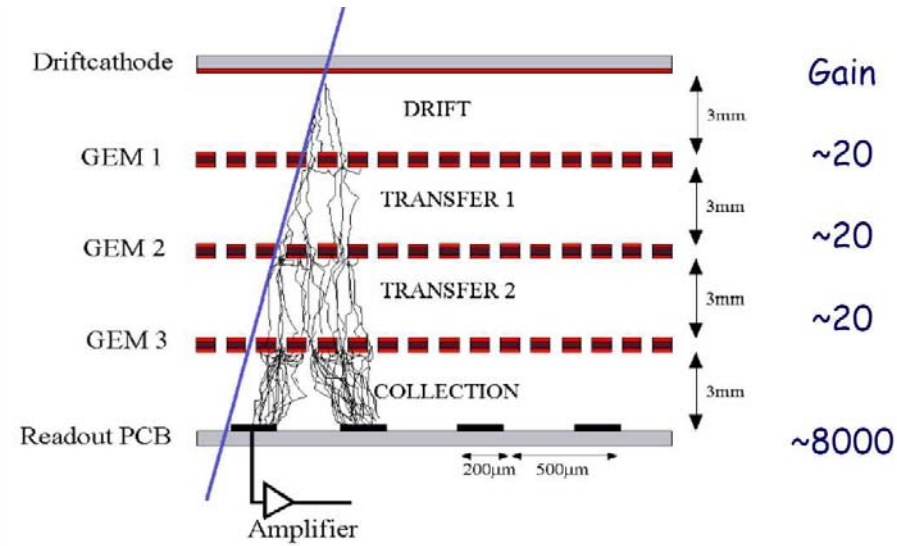
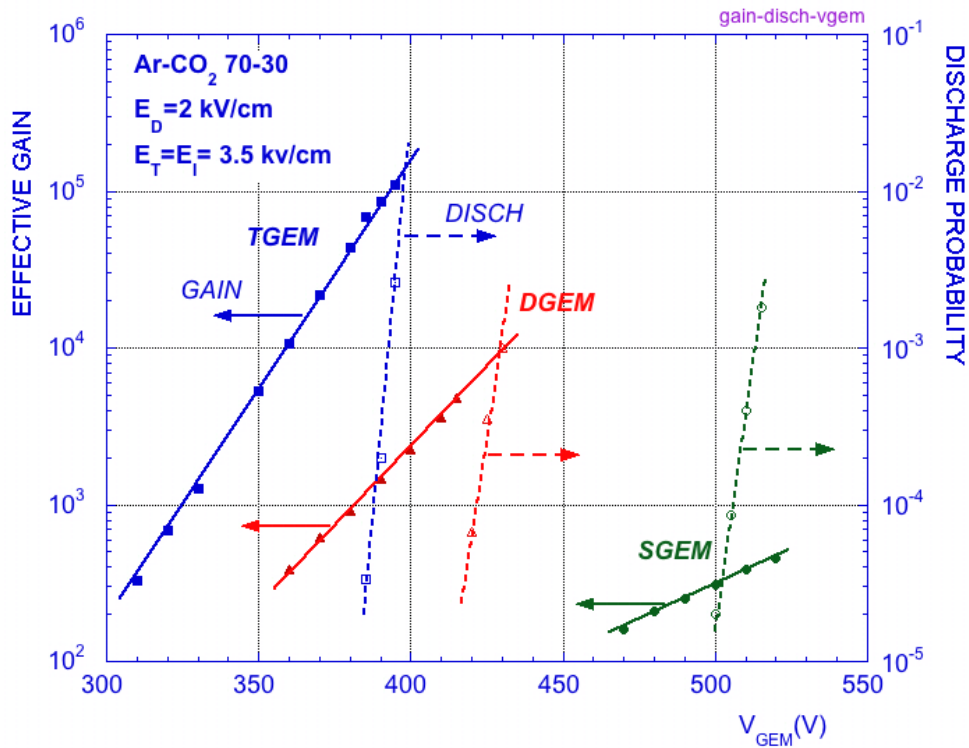
**NA49-future**

All detectors use three GEM foils in cascade for amplification to minimize discharge probability by reducing field strength.

# Multi-GEM Detectors

## Discharge Probability on Exposure to 5 MeV Alphas

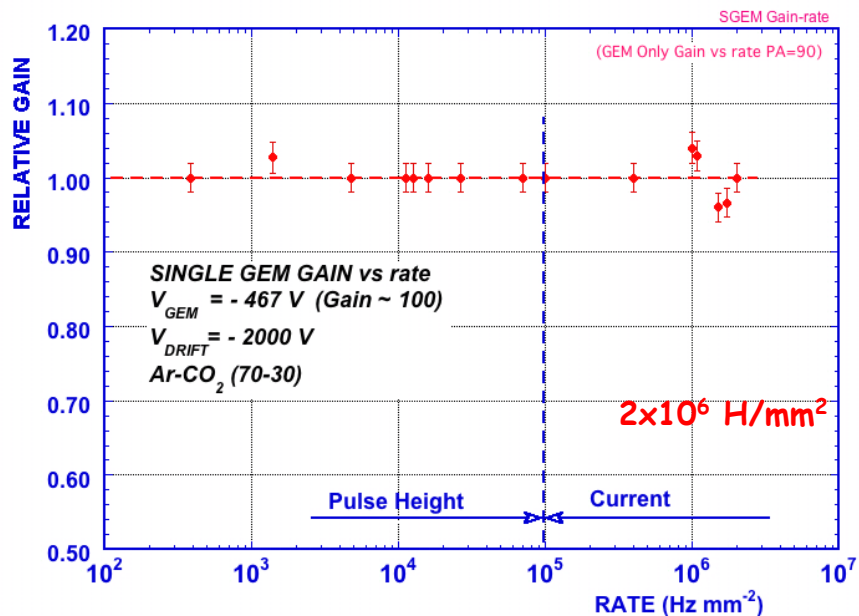
Multiple structures provide equal gain at lower voltage.  
 Discharge probability on exposure to  $\alpha$  particles is strongly reduced.



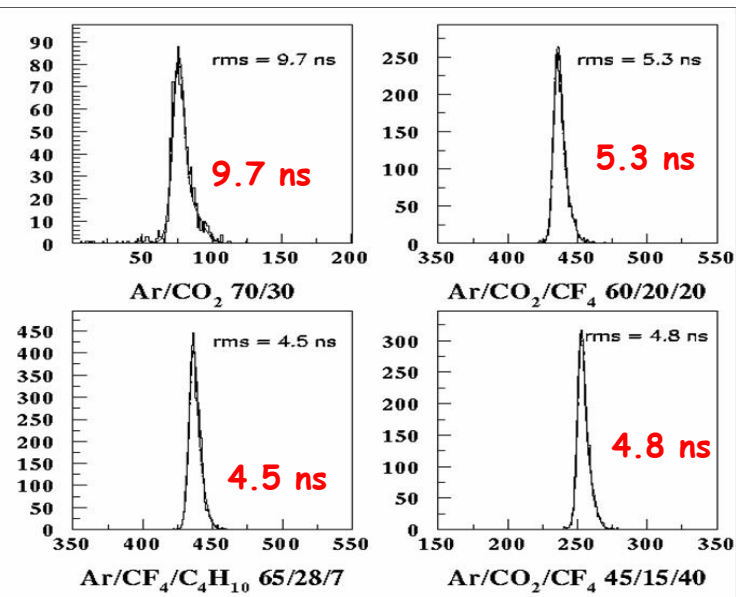
S. Bachmann et al Nucl. Instr. and Meth. A479(2002)294



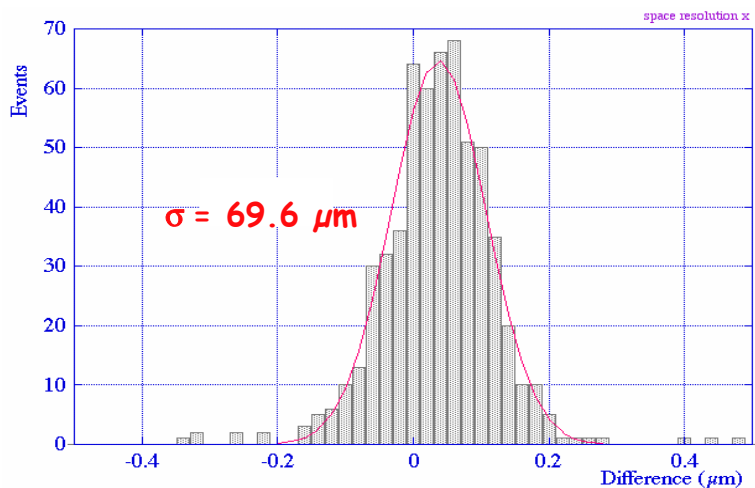
# GEM - Gas Electron Multiplier



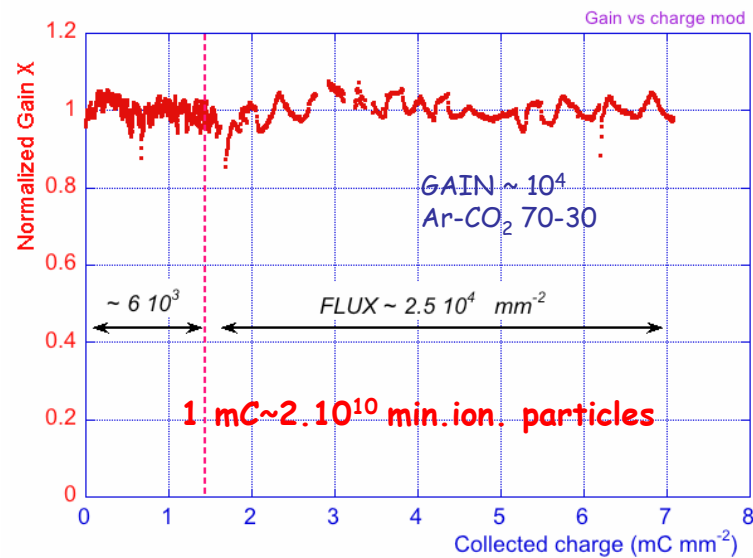
Rate capability



Time resolution



Space resolution

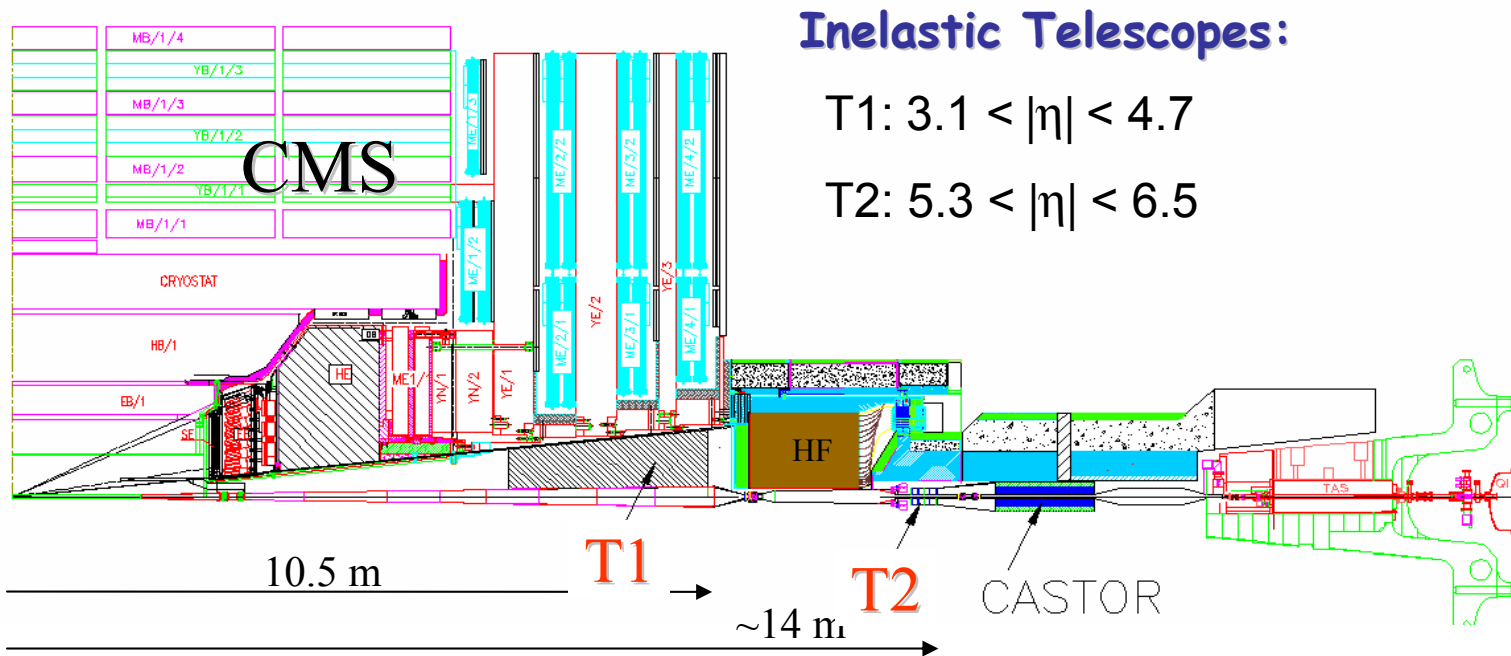


Ageing properties

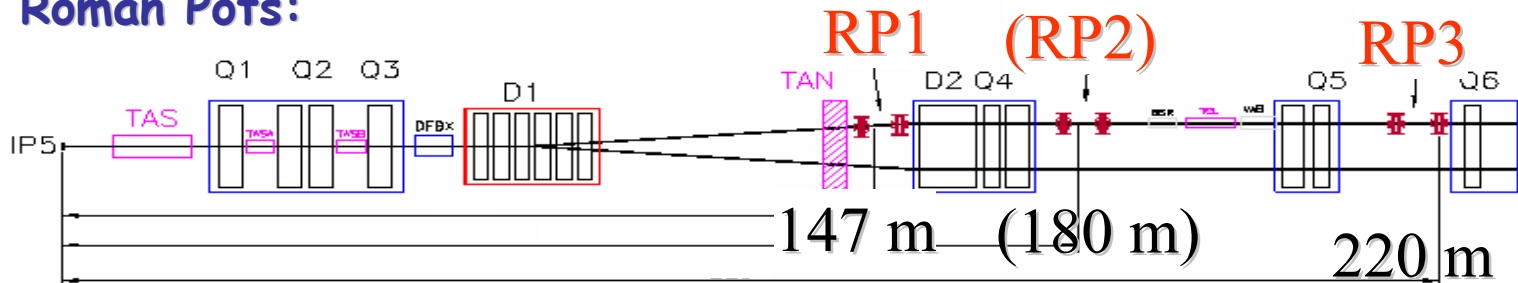


# TOTEM Detectors

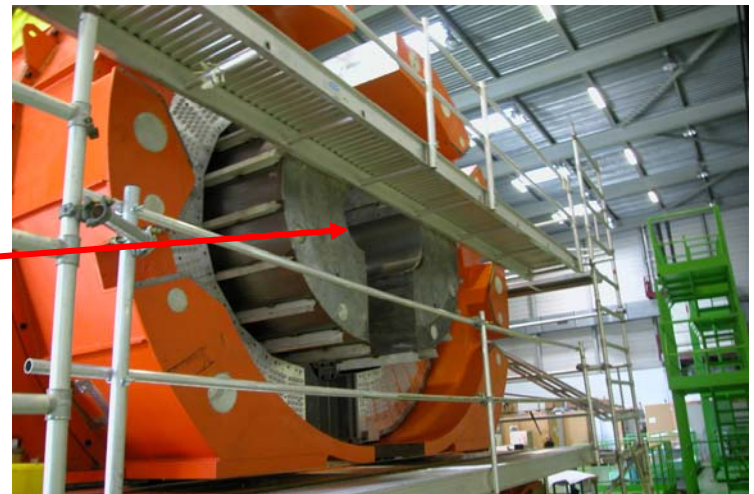
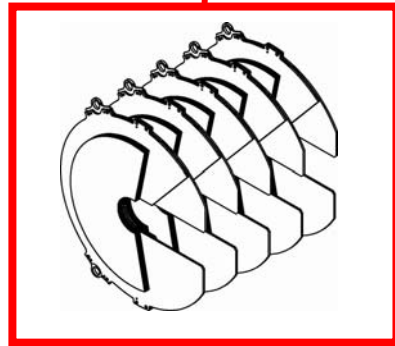
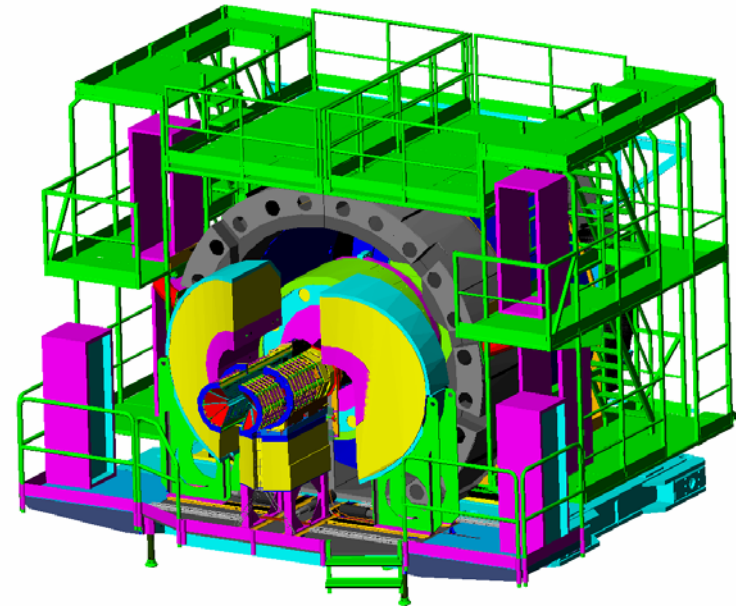
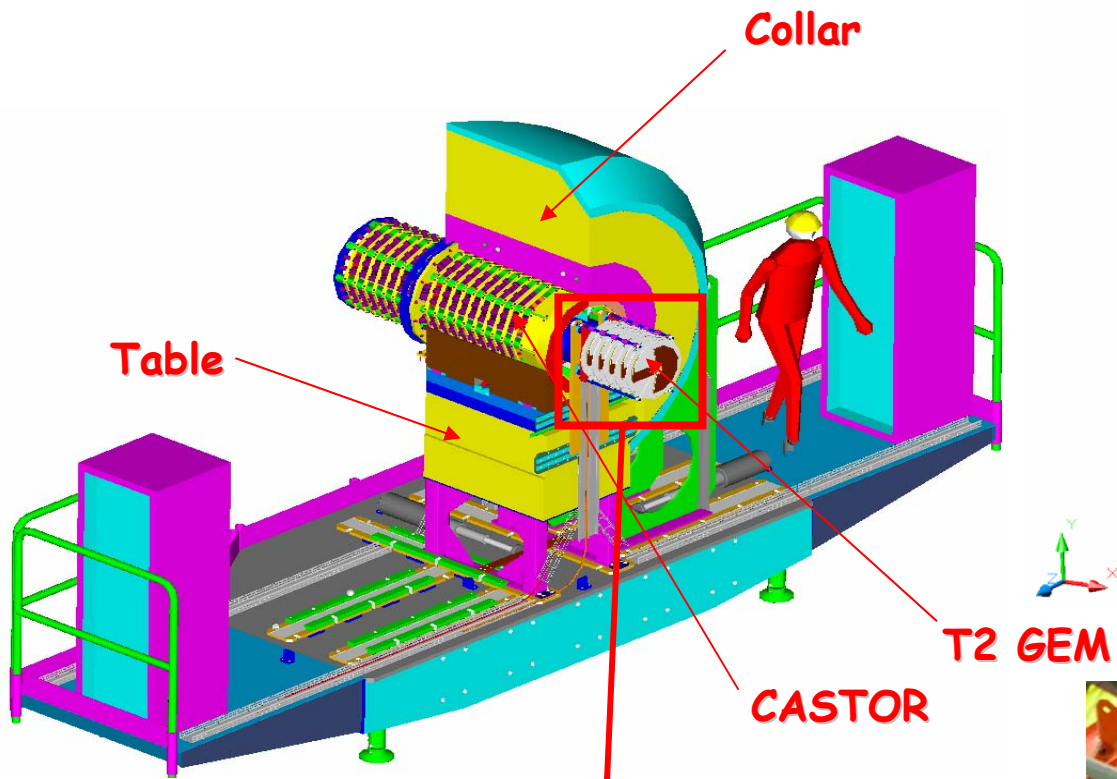
to measure total pp cross section and study elastic scattering and diffractive dissociation at the LHC



## Roman Pots:



# T2 Telescope

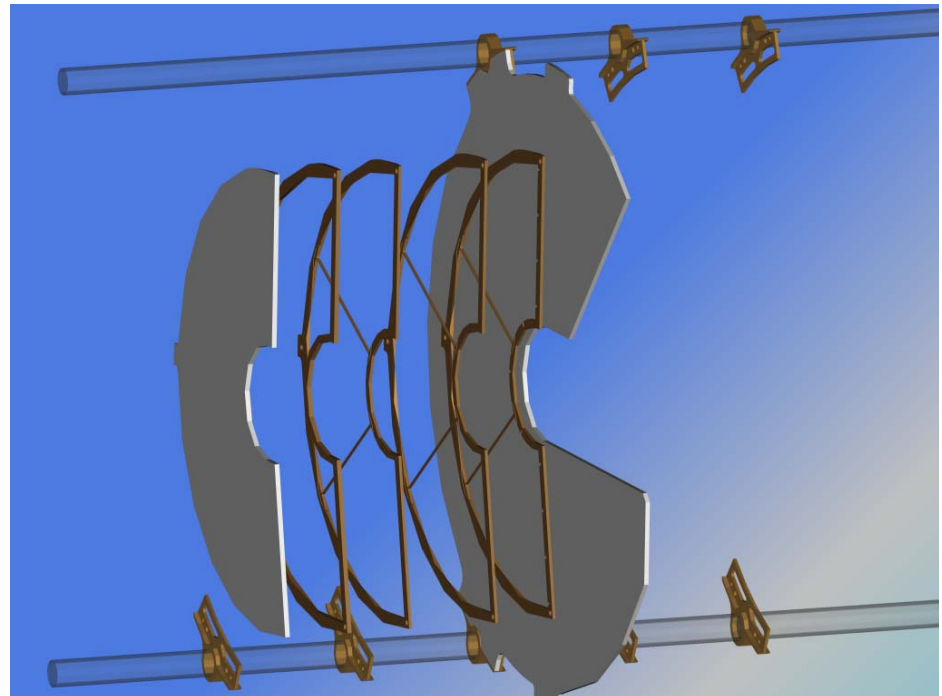
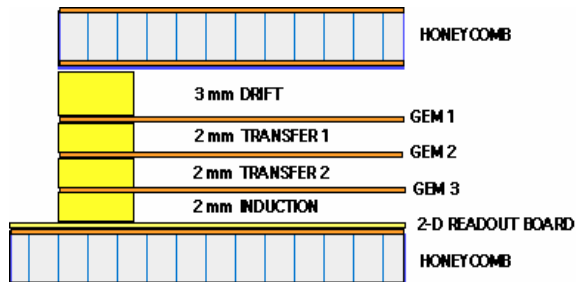
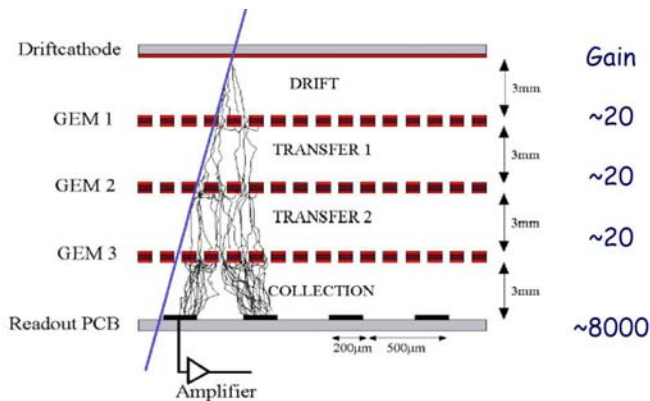


10 detector planes on each side of IP

# TOTEM GEM : Concept and Design

## Detector requirements:

- Rate Capability** - Charge particle rates  $10^4 \text{ p mm}^{-2}\text{s}^{-1}$  at  $\mathcal{L} = 10^{33} \text{ cm}^{-2}\text{s}^{-1}$
- Ageing** - 1 year of continuous operation  $10^{11} \text{ p mm}^{-2} \rightarrow 7 \text{ mC mm}^{-2}$
- Discharges** - at probability of  $10^{-12}/\text{part.} \rightarrow 10 \text{ disch. cm}^{-2} \text{ year}^{-1}$
- Time Resolution** -  $< 10 \text{ ns}$
- Space Resolution** -  $< 100 \mu\text{m}$
- Efficiency** -  $> 97 \%$



# TOTEM GEM 2004 Prototype: Concept and Design

65( $\phi$ ) x 24( $\eta$ ) = 1560 pads

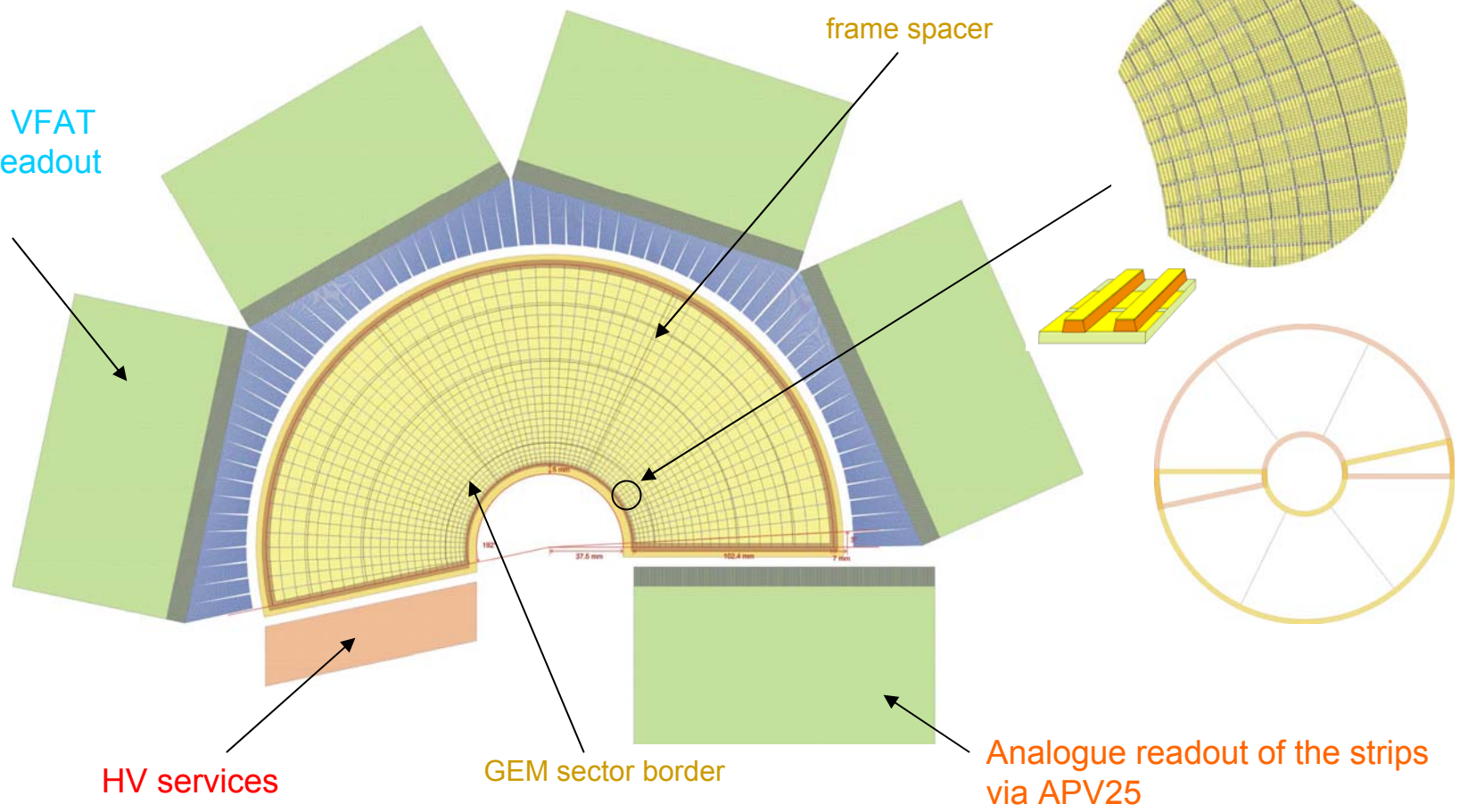
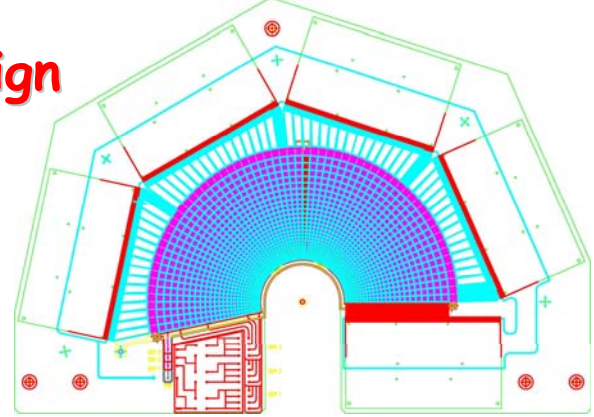
Pads:

2x2 mm<sup>2</sup> – 7x7 mm<sup>2</sup>

Strips:

256 equidistant (80  $\mu$ m wide, 400  $\mu$ m pitch)

Pads  
Trigger: VFAT  
Digital readout



frame spacer

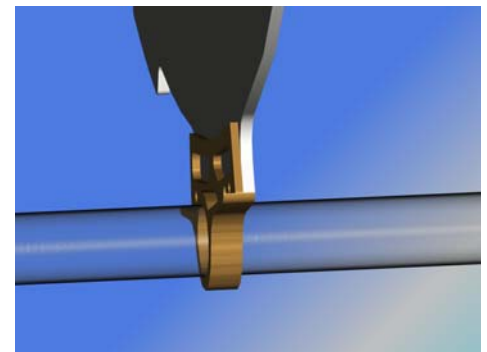
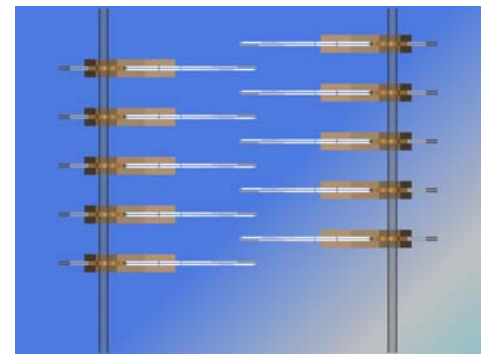
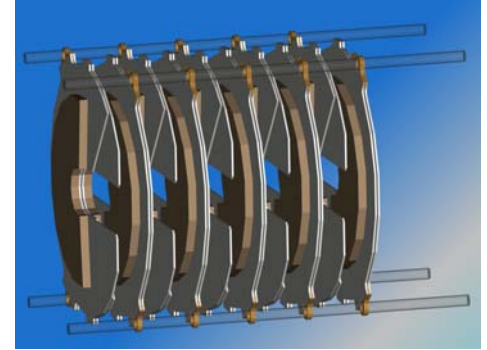
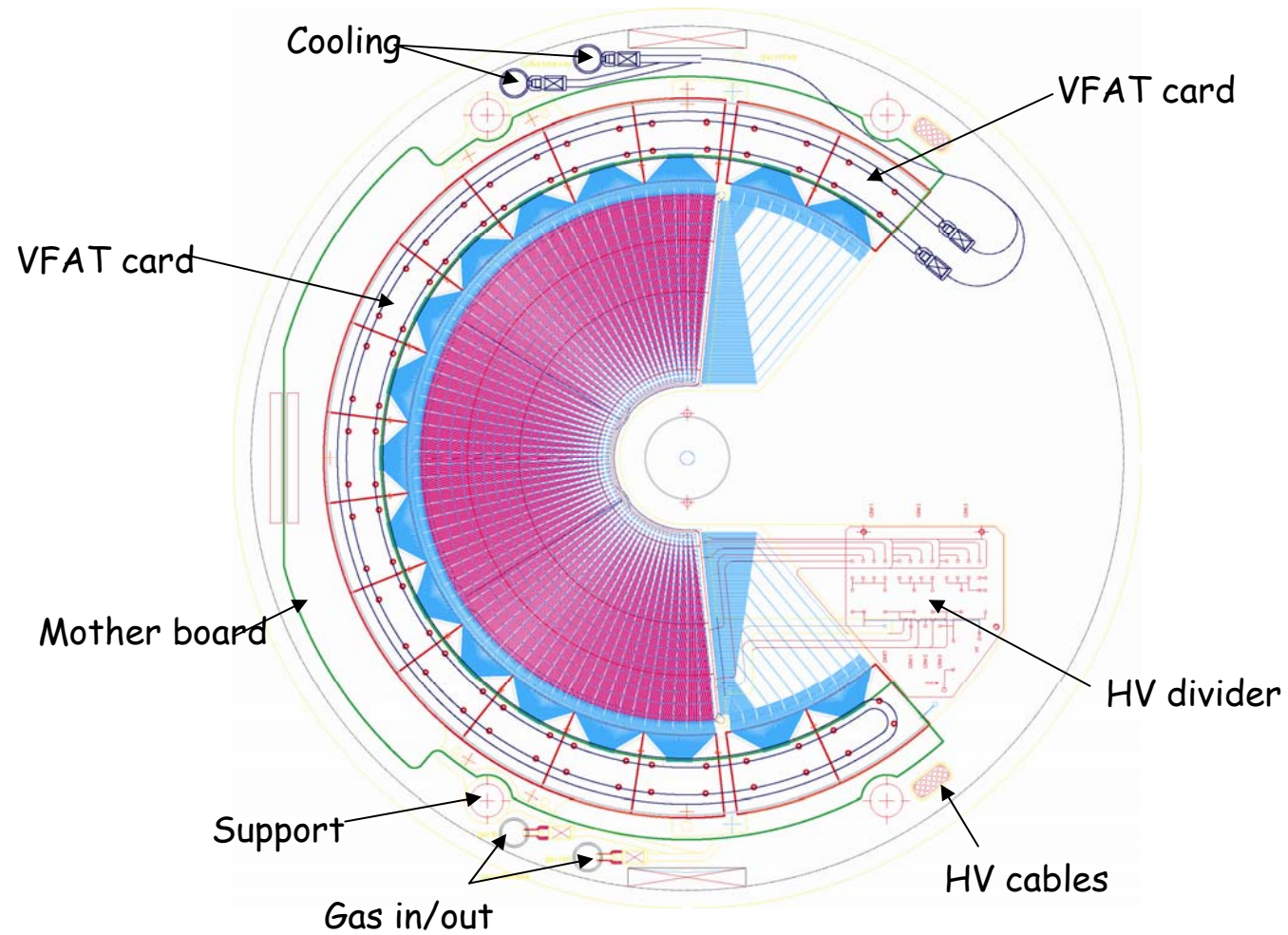
HV services

GEM sector border

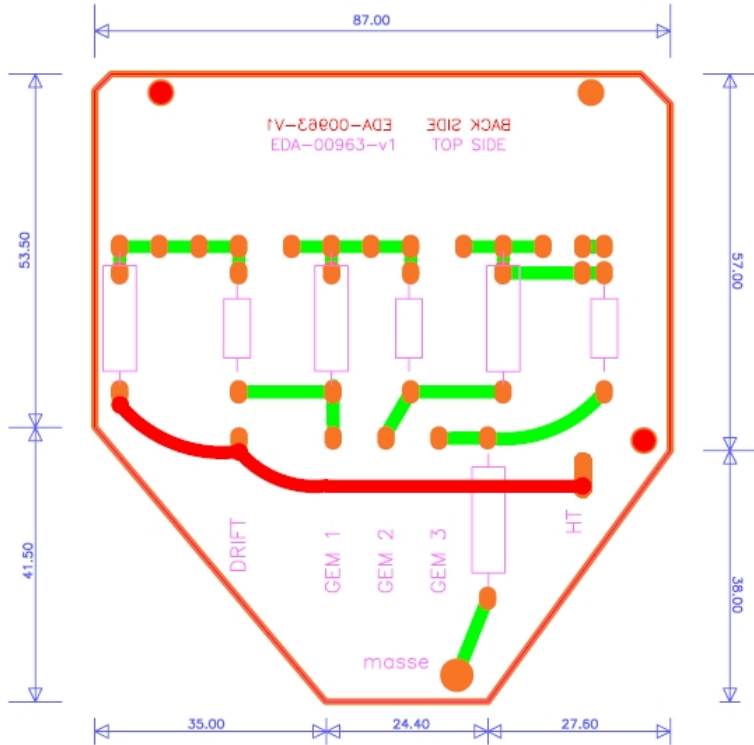
Analogue readout of the strips  
via APV25



# TOTEM GEM Final Detector Module

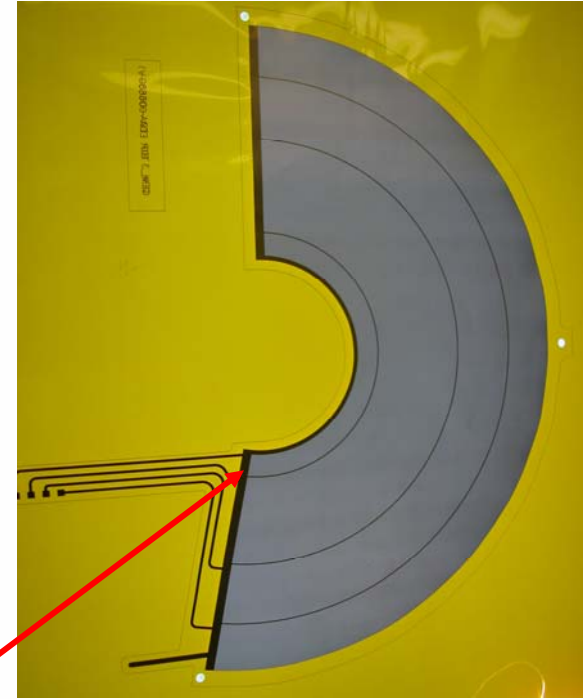
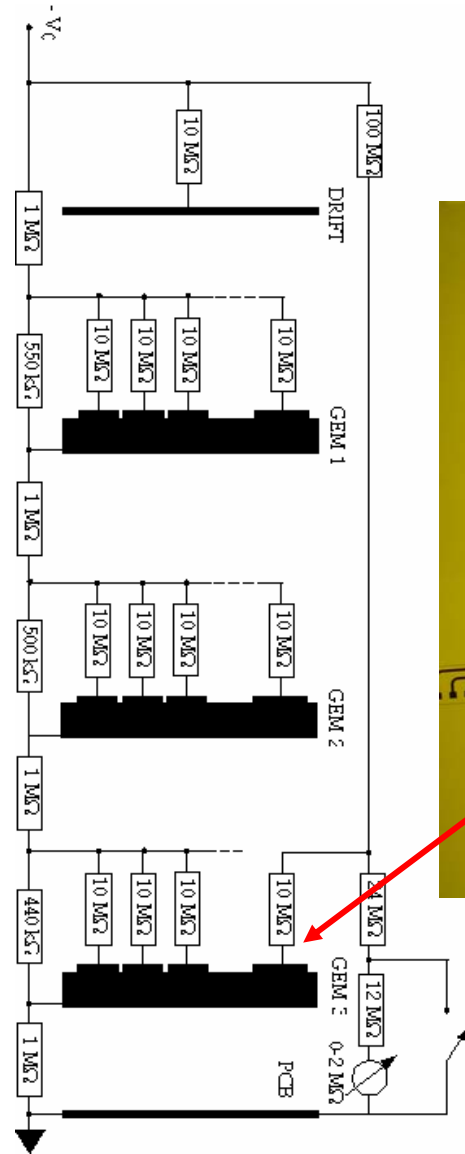


# TOTEM GEM HV Divider



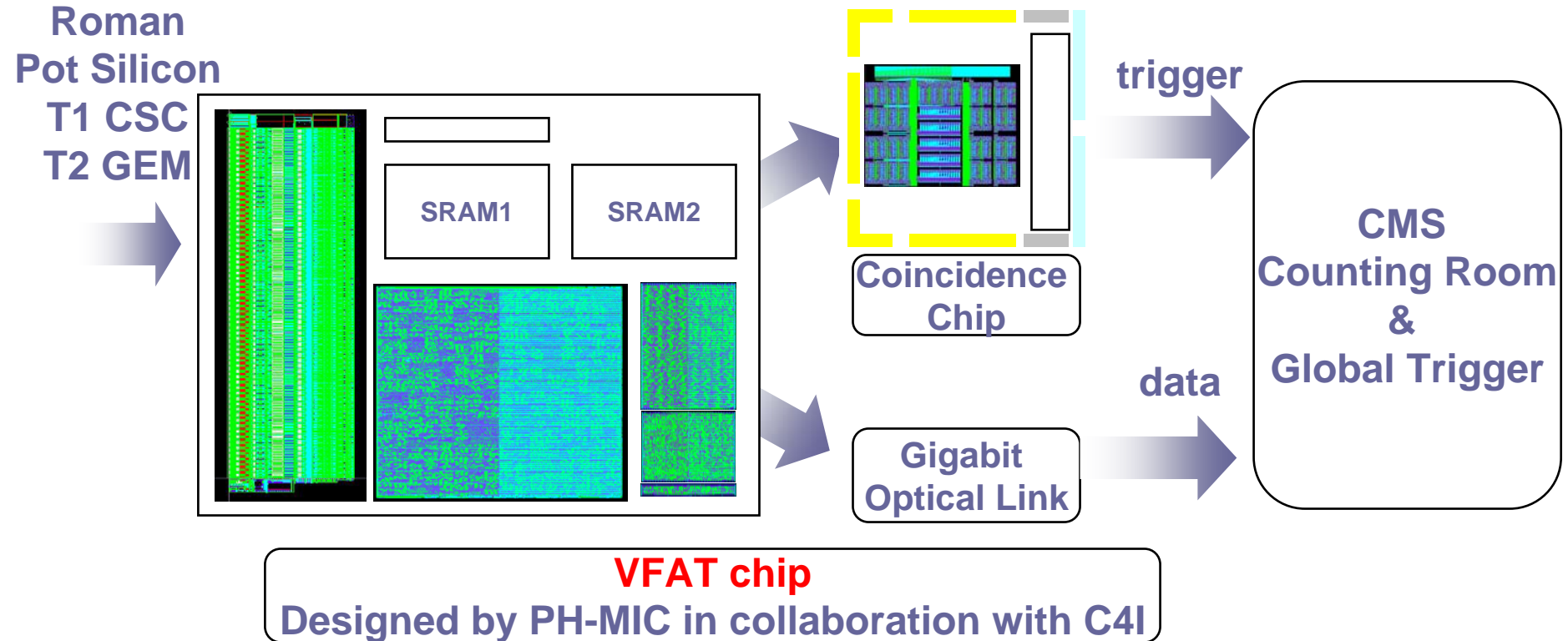
top side

	EDA-00963-V1	INDICE	NBRE DE COUCHE : 2
	DESS SANCHEZ M.	-	EP. DU CUIVRE : 35um
TS/DEM	DATE 01/06/2005		EP. DU CIRCUIT : 05/10
			MATIERE DU CI : FR4



Bottom GEM foil

# Electronics



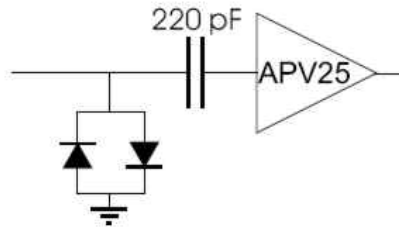
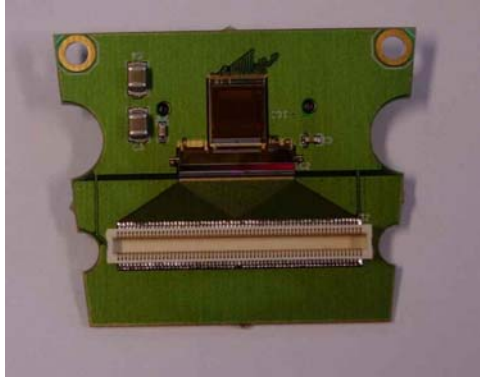
- VFAT and Coincidence Chip very close to submission
- VFAT 128 channels with front end and comparator with adjustable threshold
- VFAT/CC design team: P. Aspell, G. Anelli, J. Kaplon, K. Kloukinas, W. Snoeys, H. Mugnier, P. Chalmet (CERN-C4i)

# VFAT Front End Specs

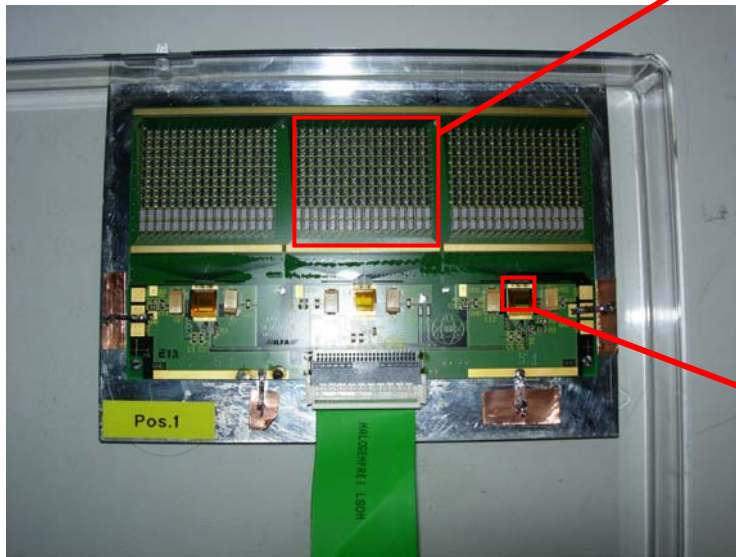
- **Pulse Gain** at discriminator input; 53mV/fC (simulated for maximum charge collection time)
- **Integral nonlinearity error:**
  - <1% for input charge 0 to 12fC
  - <3% for input charge 0 to 16fC
- **Peaking time;** 22.5ns (simulated for 3.5fC input charge and maximum charge collection time)
- **Power consumption** for nominal bias condition; 1.9mW/channel (250mW for whole front end)
- **Noise** performance for nominal bias condition;
  - <1000 e- rms for  $C_{input} = 10\text{pF}$
  - <1400 e- rms for  $C_{input} = 20\text{pF}$
- **Maximum load of the analogue test outputs;** <5pF



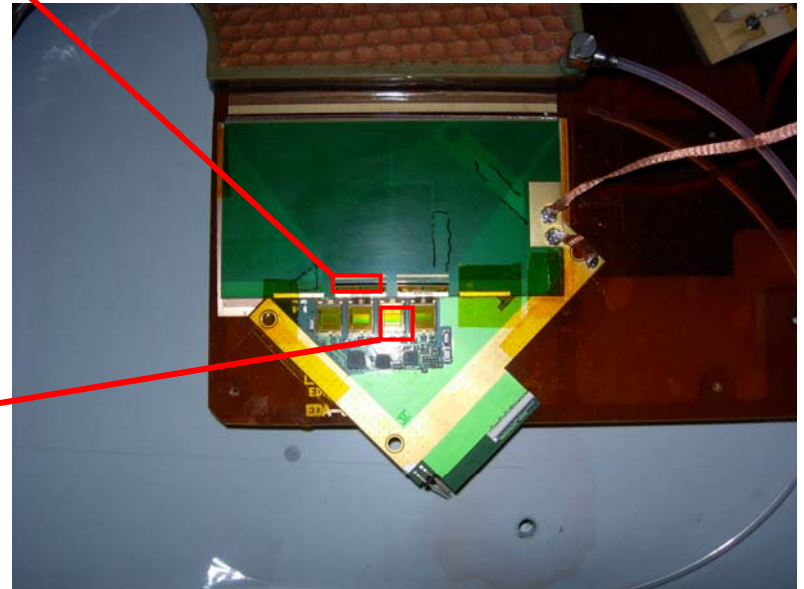
# Discharge Protection Circuit



Protection Circuit



COMPASS



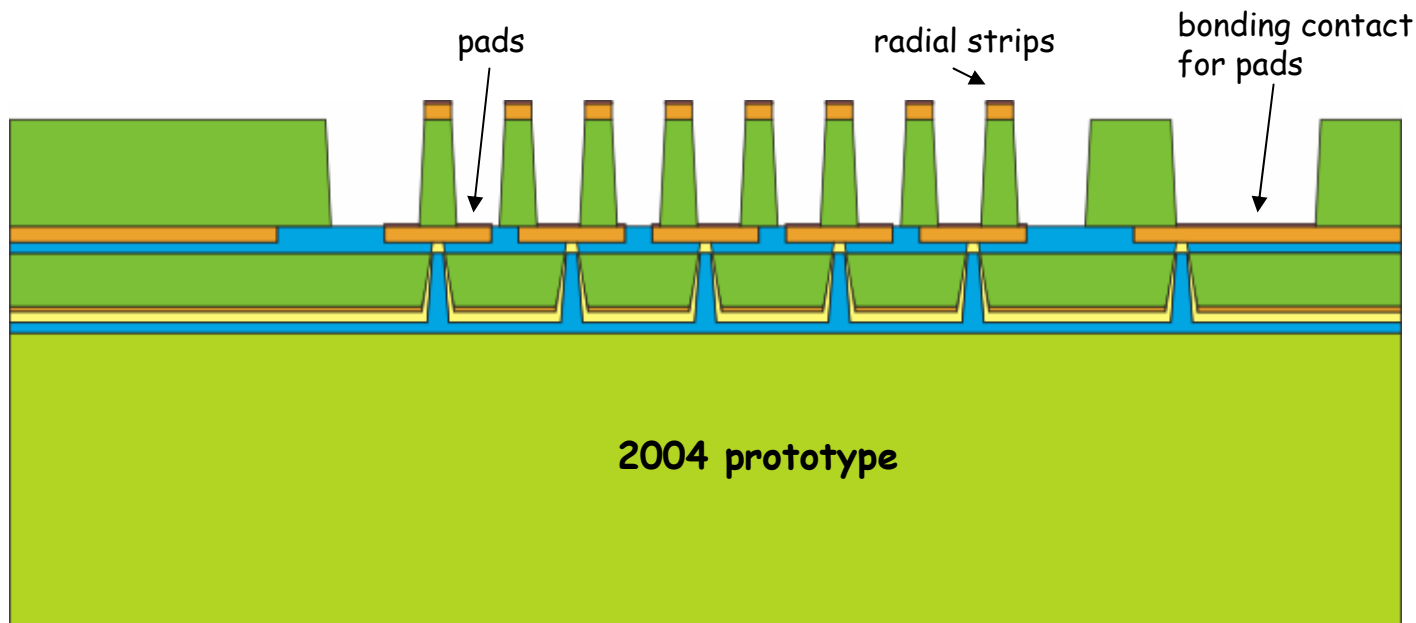
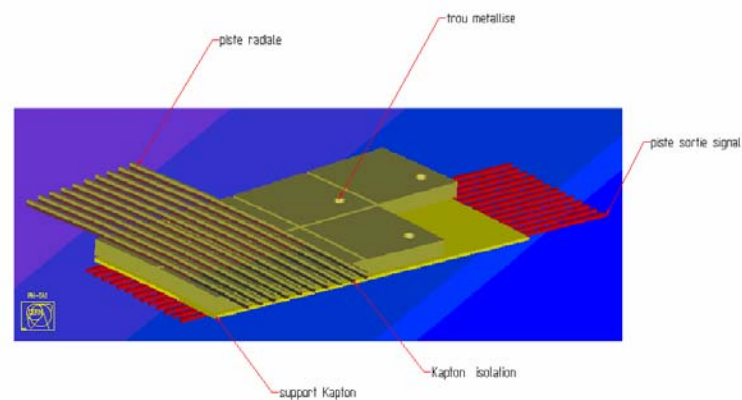
APV chip

TOTEM

# TOTEM GEM - Readout Board

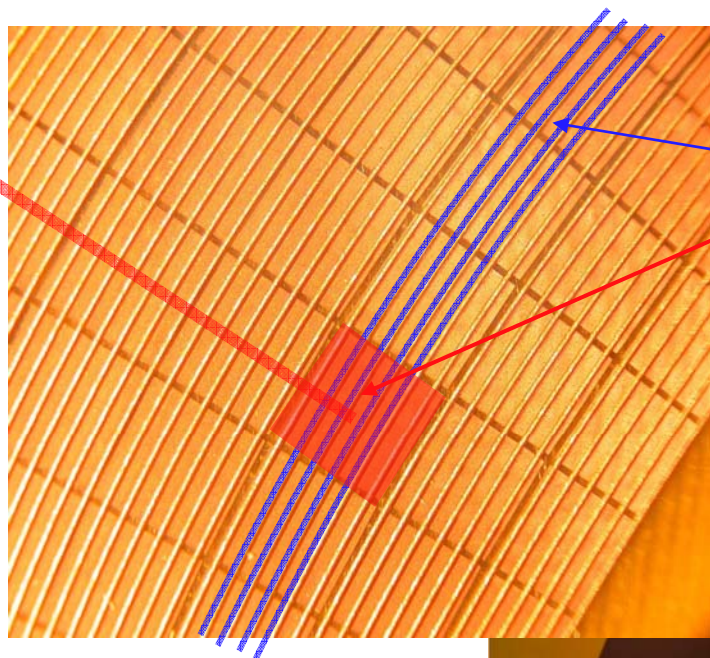


IMAGE DU CIRCUIT DE LECTURE



- Ni Au
- 15  $\mu\text{m}$  Cu
- 50  $\mu\text{m}$  Polyimide
- 15  $\mu\text{m}$  Cu
- Epoxy glue
- 25  $\mu\text{m}$  Polyimide
- 5  $\mu\text{m}$  Cu
- 10  $\mu\text{m}$  Cu
- Epoxy glue
- 125  $\mu\text{m}$  FR4

# TOTEM GEM - Readout Board



TOTEM READOUT BOARD:

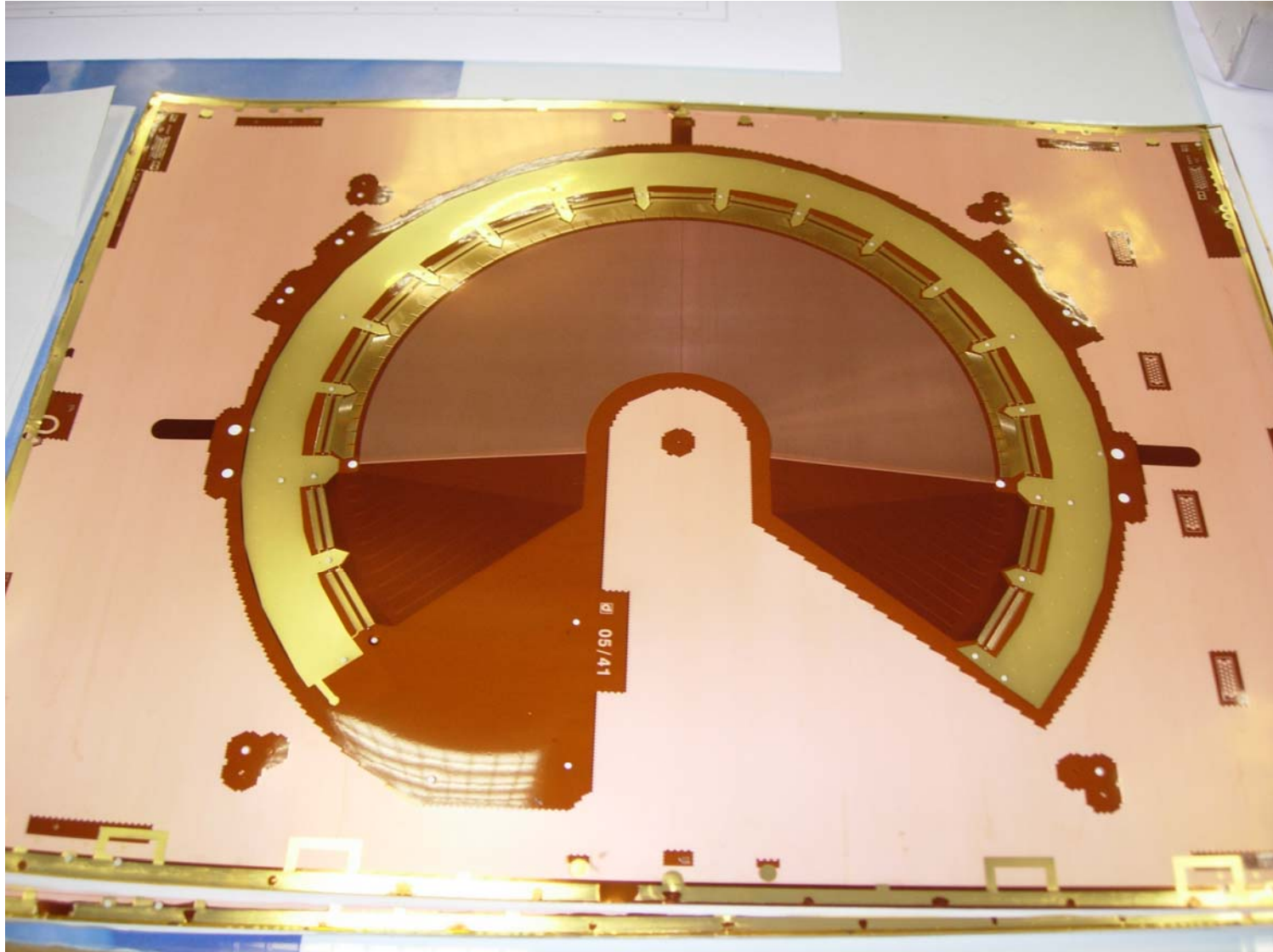
Radial strips (accurate track's angle)

Pad matrix (fast trigger and coarse coordinate)



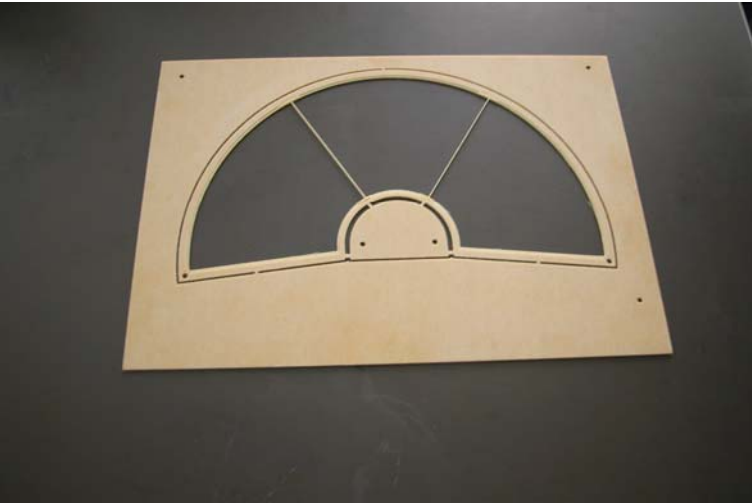


# TOTEM GEM - Readout Board

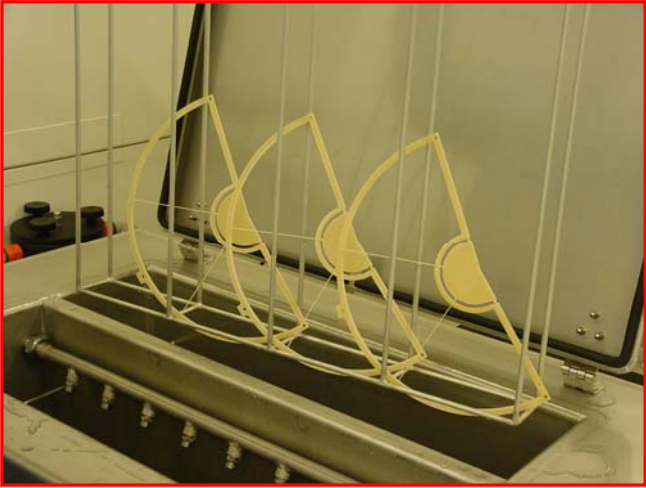




# GEM Frames



Machining



Cleaning

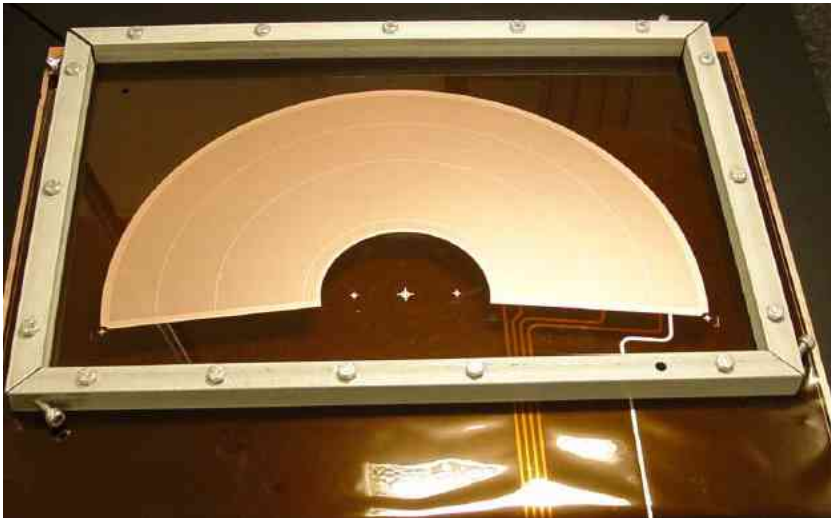
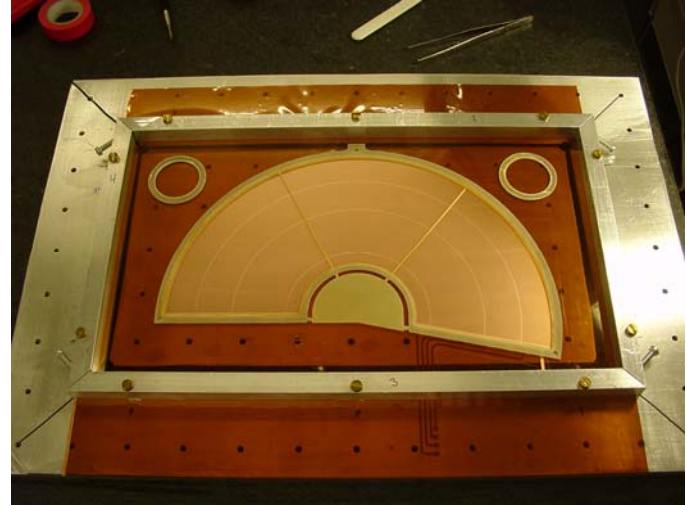
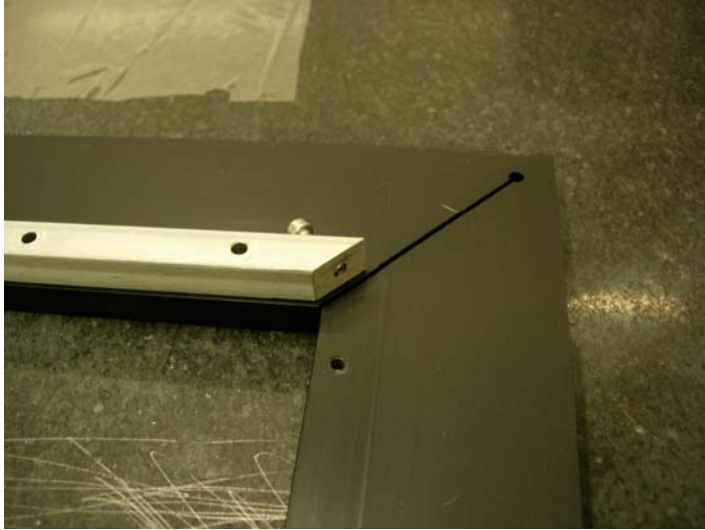


Varnishing and Drying

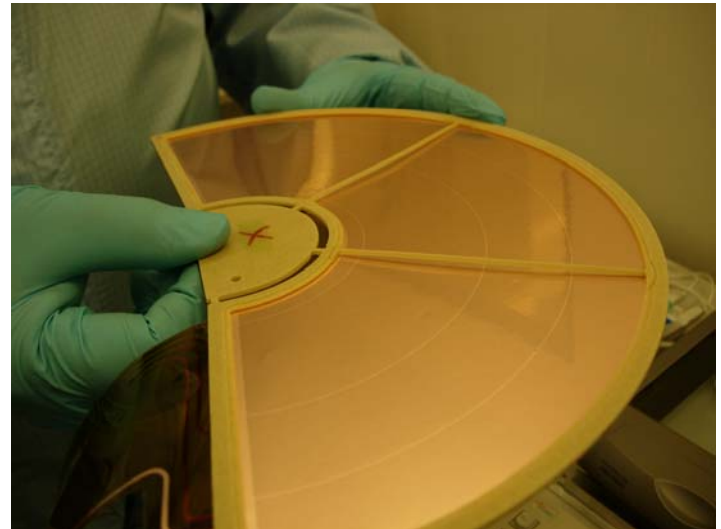


HV Test 5kV

# GEM Foil Stretching and Gluing

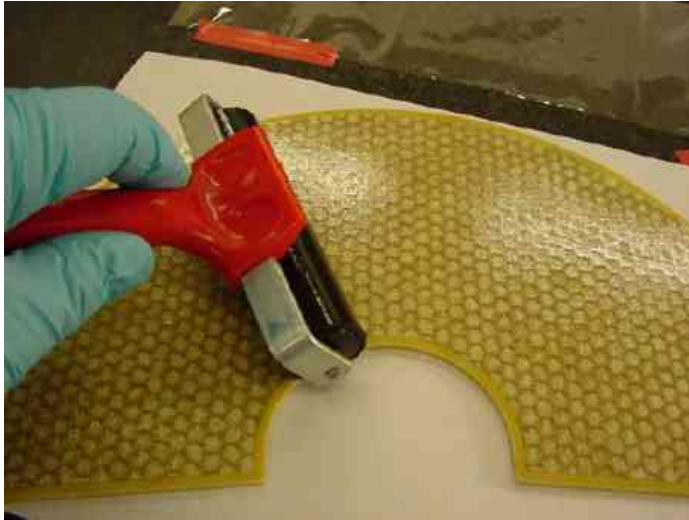


Stretching



Gluing

# Support Planes and Sandwich



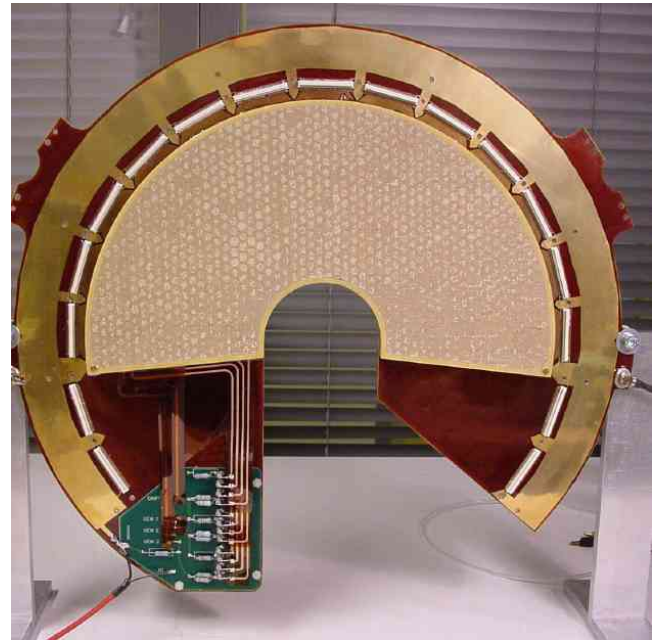
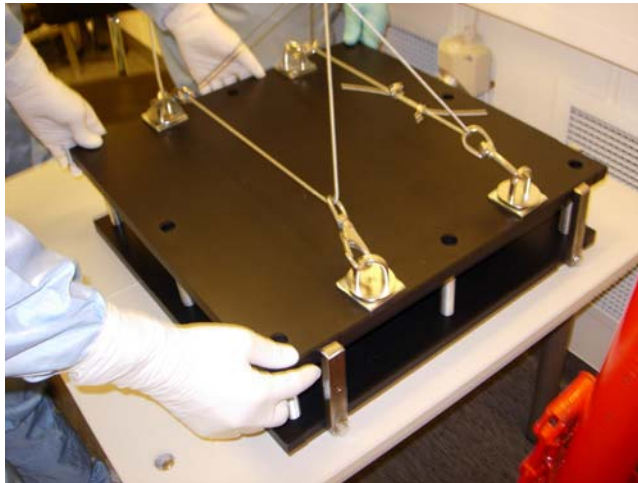
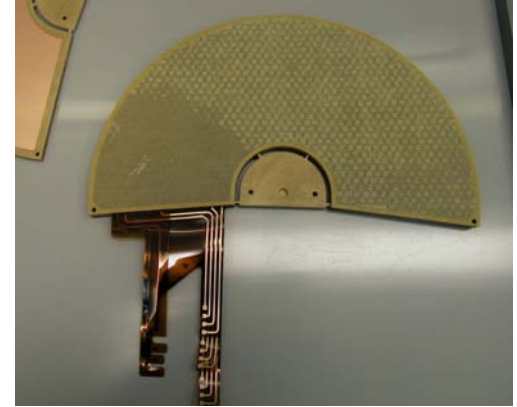
Support and Drift Electrode



Assembling together



# Detector Assembly



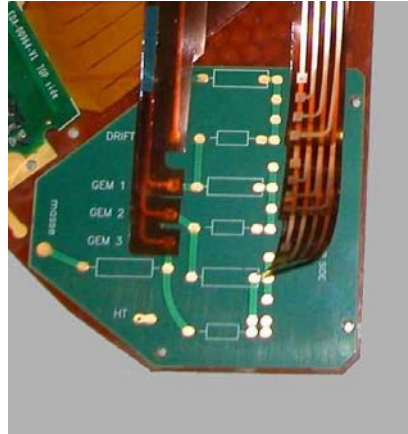


# Final Detector Module

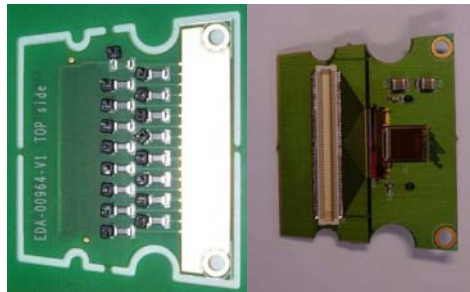
Gas tightness test

HV test with  $N_2$  for external discharges

Performance test with test cards



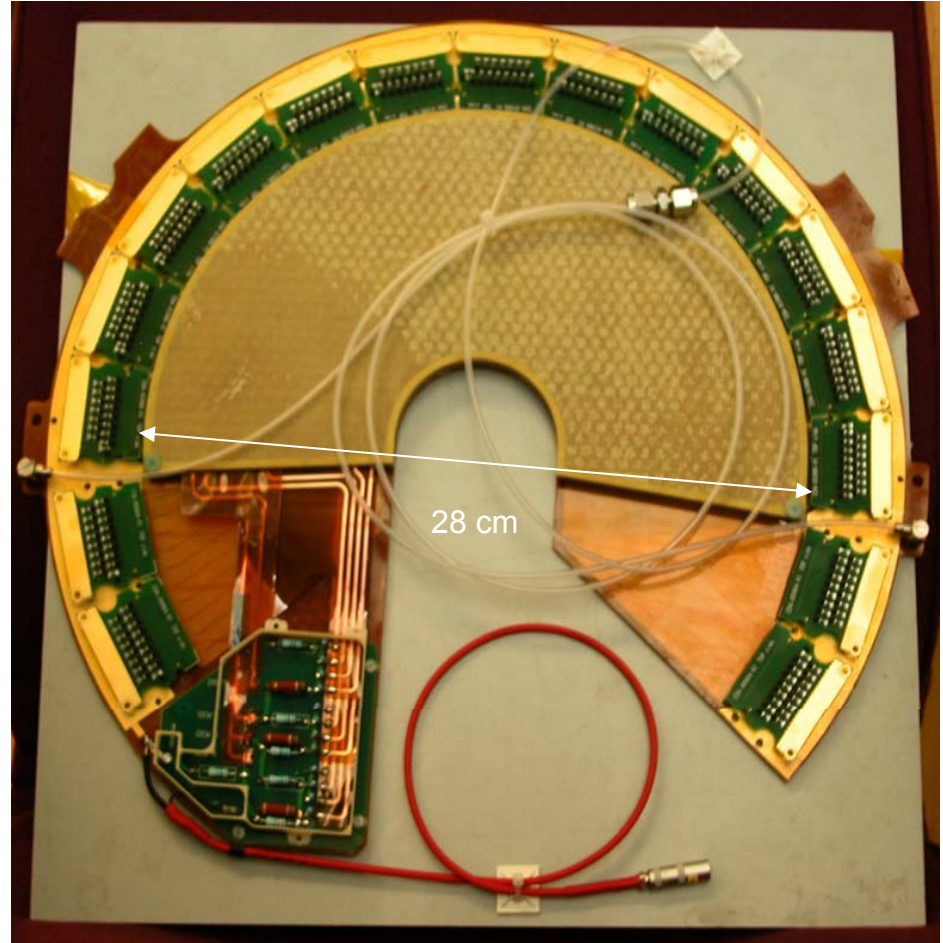
HV resistor divider board



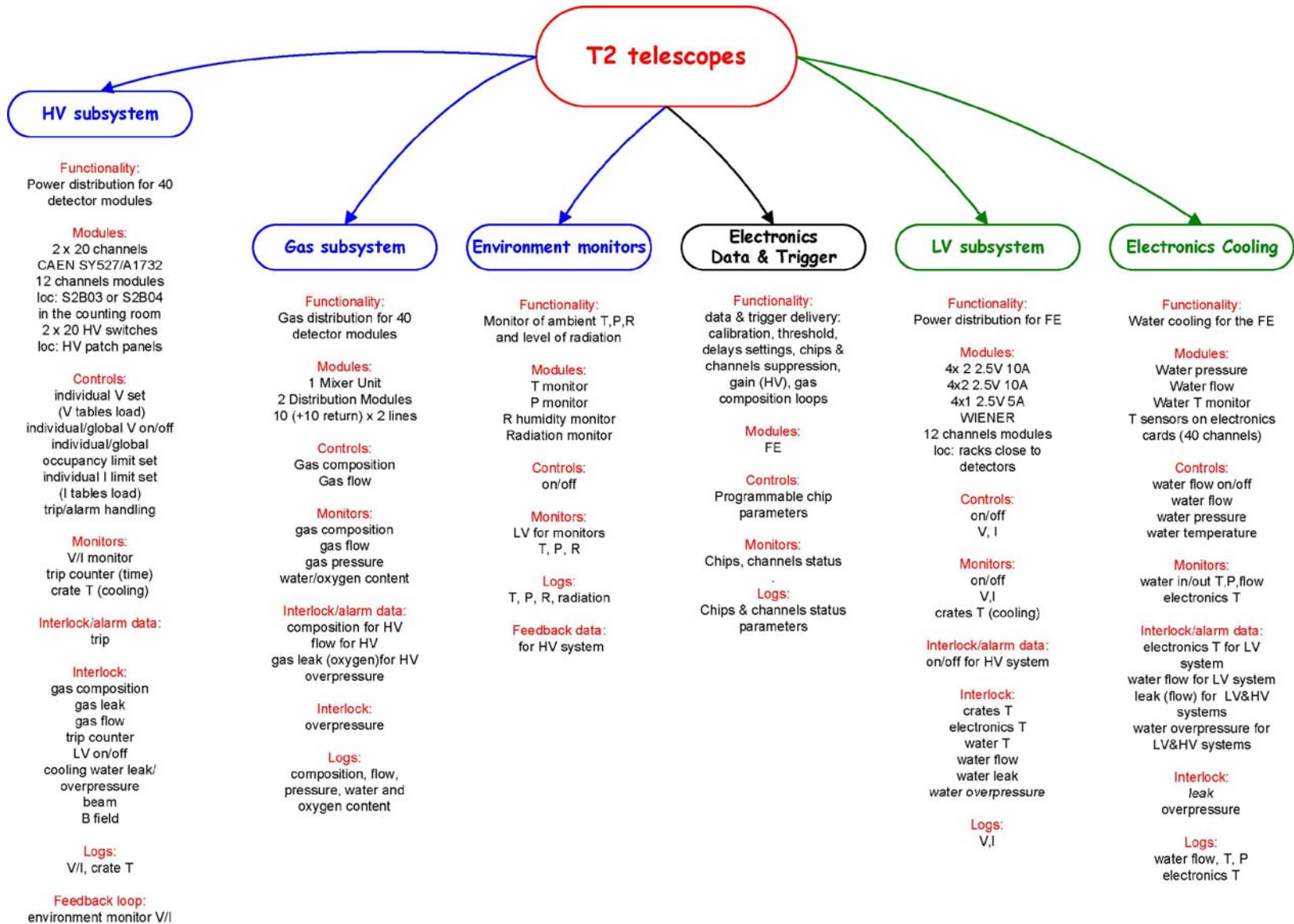
Test Cards



No bonding anymore



# T2 DCS Requirements Chart



# T2 HV Flow Chart

